## Applicant(s)/Patent Under Application/Control No. Reexamination 10/718,806 YEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2613 David C. Payne **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 07-2004 385/140 US-2004/0136680 Medina et al. Α US-В US-С US-D US-Ε US-F US-G US-Н USī US-J US- · Κ US-L US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W Χ

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